

Notice of References Cited	Application/Control No. 10/044,195		Applicant(s)/Patent Under Reexamination SYED, MAJID	
	Examiner Thuong (Tina) T. Nguyen		Art Unit 2155	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0044567 A1	04-2002	Voit et al.	370/467
*	B	US-5,935,218 A	08-1999	Beyda et al.	709/251
*	C	US-5,615,249 A	03-1997	Solondz, Max A.	455/450
*	D	US-6,782,510 B1	08-2004	Gross et al.	715/257
*	E	US-2003/0009765 A1	01-2003	Linden et al.	725/95
*	F	US-6,944,430 B2	09-2005	Berstis, Viktors	455/186.1
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.